## Application/Control No. Applicant(s)/Patent Under Reexamination 10/764,515 LEE, CHUN-LIANG Notice of References Cited Art Unit Examiner Page 1 of 1 2181 David E. Martinez **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Name Classification MM-YYYY US-2002/0049877 A1 04-2002 Lin, Chun-Ping 710/305 Α \* 07-2001 Sheikh et al. 710/100 US-6,266,721 B1 В

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